Search Notes



Application/Control No.

10/509,966

Examiner

TUAN A. PHAM

Applicant(s)/Patent under Reexamination

KANEKO, ICHIRO

Art Unit

2618

SEARCHED						
Class	Subclass	Date	Examiner			
455	63.1	11/25/2006	РНАМ			
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	67.13					
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375	346	11/27/2006	PHAM			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
See interference search printout		11/27/2006	PHAM		

(INCLUDING S	RCH NOT SEARCH	STRATEGY)
		DATE	EXMR
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Interference search		11/27/2006	PHAM
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